

P-Channel 30V(D-S) MOSFET

Product summary		
V_{DS}	-30	V
$R_{DS(ON)}$ (at $V_{GS}=-10V$) Typ.	16	m Ω
$R_{DS(ON)}$ (at $V_{GS}=-4.5V$) Typ.	21	m Ω
I_D ($T_A=25^\circ C$)	-10	A

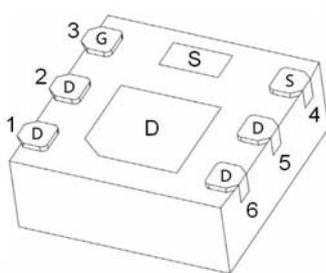
Features

- Trench Power LV MOSFET technology
- Low $R_{DS(ON)}$
- RoHS and Halogen-Free compliant

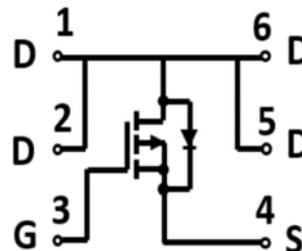
Applications

- Load switch
- Battery charge

Pin Configuration



DFN2X2-6L



Packing Information

Device	Reel Size	Quantity(Min. Package)
EC4101	7"	3000pcs

Absolute Maximum Ratings (at $T_A=25^\circ C$ Unless Otherwise Noted)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	-30	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current	$T_A=25^\circ C$	-10
		$T_A=70^\circ C$	-8.2
I_{DM}	Pulse Drain Current Tested ^A	-30	A
P_D	Power Dissipation	2.8	W
T_J, T_{STG}	Junction and Storage Temperature Range	-55 to +150	$^\circ C$

Thermal Characteristics

Symbol	Parameter	Typical	Units
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient ^B	45	$^\circ C/W$

Electrical Characteristics (at $T_J = 25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
Static Parameters						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=-250\mu A$	-30	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=-30V, V_{GS}=0V$	--	--	-1	μA
I_{GSS}	Gate-Body Leakage Current	$V_{DS}=0V, V_{GS}=\pm 20V$	--	--	± 100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu A$	-1.0	-1.6	-2.5	V
$R_{DS(on)}$	Drain-Source On-State Resistance	$V_{GS}=-10V, I_D=-8A$	--	16	21	m Ω
		$V_{GS}=-4.5V, I_D=-6A$	--	21	34	m Ω
V_{SD}	Forward Voltage	$I_S=-1A, V_{GS}=0V$	--	--	-1.0	V
I_S	Maximum Body-Diode Continuous Current		--	--	-10	A
Dynamic Parameters						
C_{iss}	Input Capacitance	$V_{GS}=0V, V_{DS}=-15V$ $f=1\text{MHz}$	--	530	--	pF
C_{oss}	Output Capacitance		--	114	--	pF
C_{rss}	Reverse Transfer Capacitance		--	75	--	pF
Switching Parameters						
Q_g	Total Gate Charge	$V_{DS}=-15V, I_D=-8A$ $V_{GS}=-10V$	--	12	--	nC
Q_{gs}	Gate-Source Charge		--	1.8	--	nC
Q_{gd}	Gate-Drain Charge		--	3	--	nC
$t_{D(on)}$	Turn-on Delay Time	$V_{DD}=-15V$ $R_L=1.8\Omega, R_{GEN}=3\Omega,$ $V_{GS}=-10V$	--	7.7	--	nS
t_r	Turn-on Rise Time		--	5.5	--	nS
$t_{D(off)}$	Turn-off Delay Time		--	26.3	--	nS
t_f	Turn-off Fall Time		--	11.5	--	nS

A. Pulse Test: Pulse Width $\leq 300\mu s$, Duty cycle $\leq 2\%$.

B. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins.

Typical Characteristics

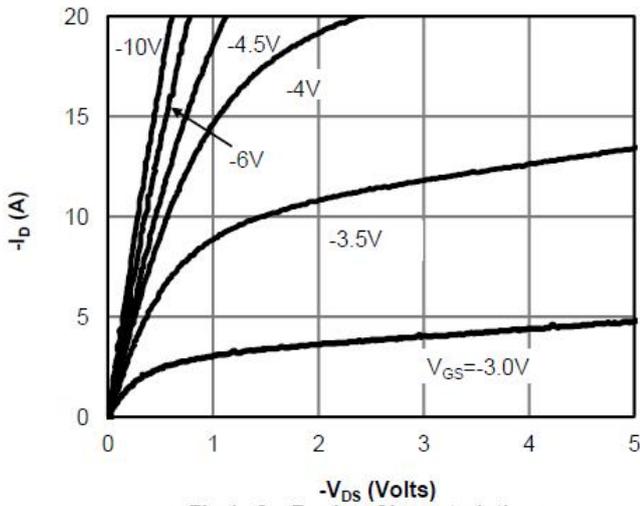


Fig 1: On-Region Characteristics

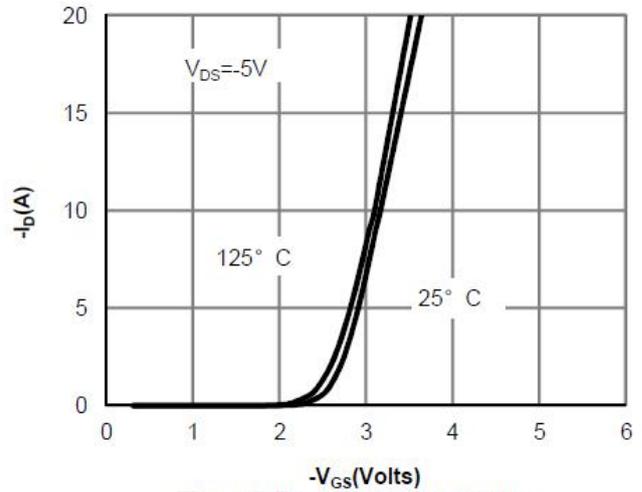


Figure 2: Transfer Characteristics

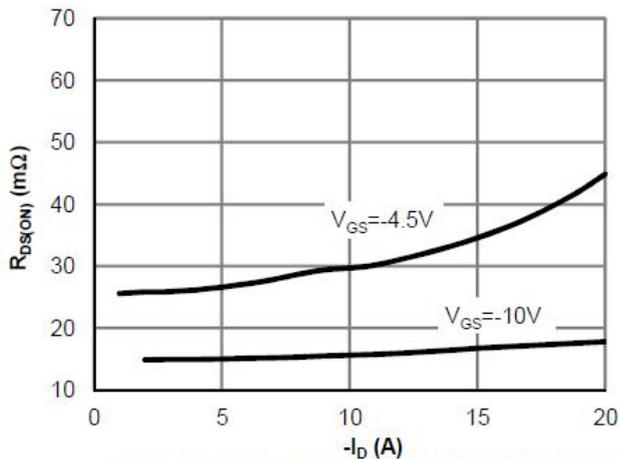


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

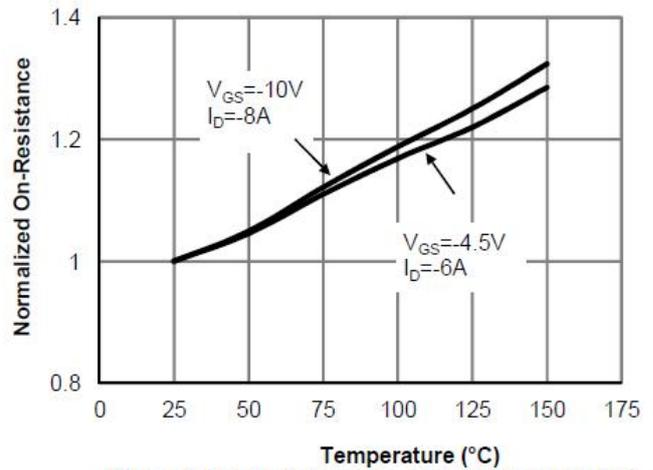


Figure 4: On-Resistance vs. Junction Temperature

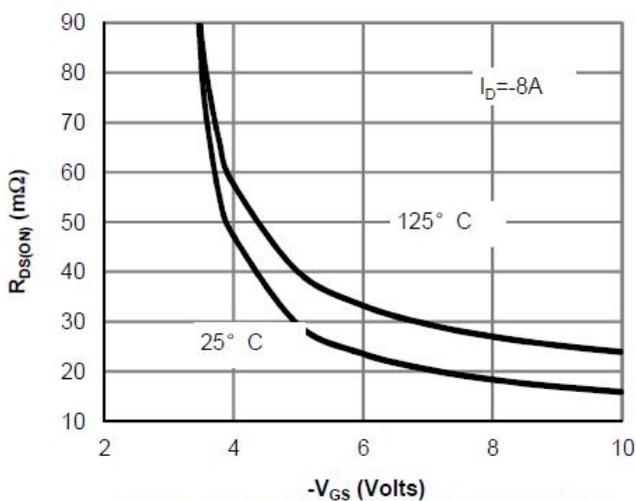


Figure 5: On-Resistance vs. Gate-Source Voltage

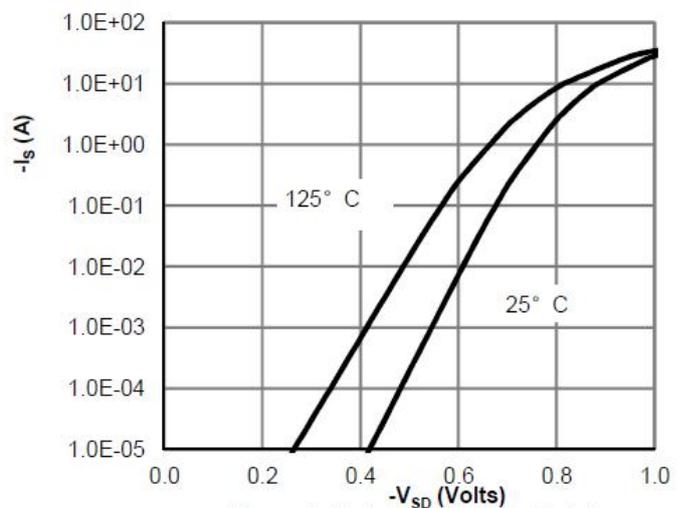


Figure 6: Body-Diode Characteristics

Typical Characteristics

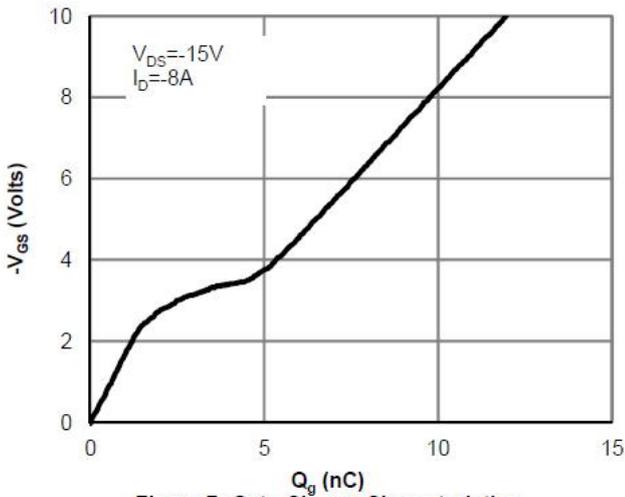


Figure 7: Gate-Charge Characteristics

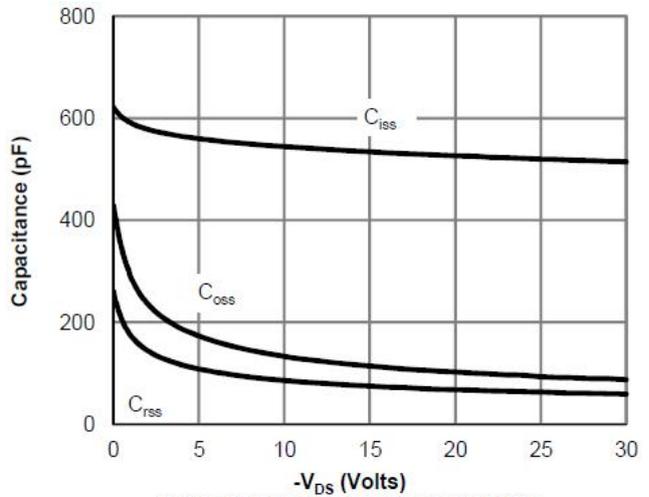


Figure 8: Capacitance Characteristics

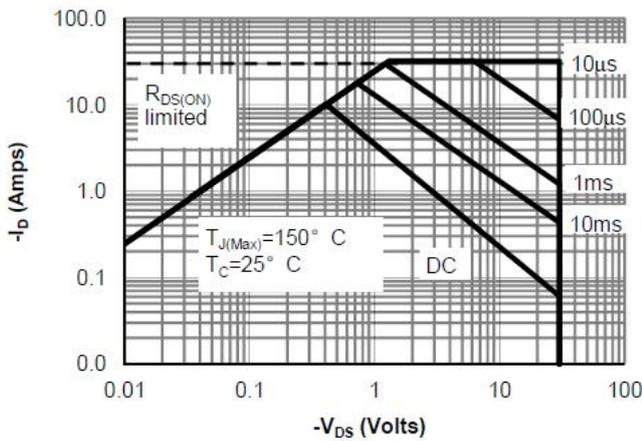


Figure 9: Maximum Forward Biased Safe Operating Area

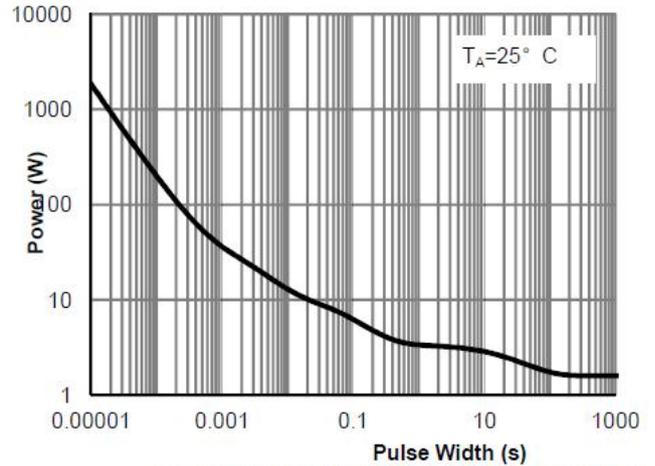


Figure 10: Single Pulse Power Rating Junction-to-A

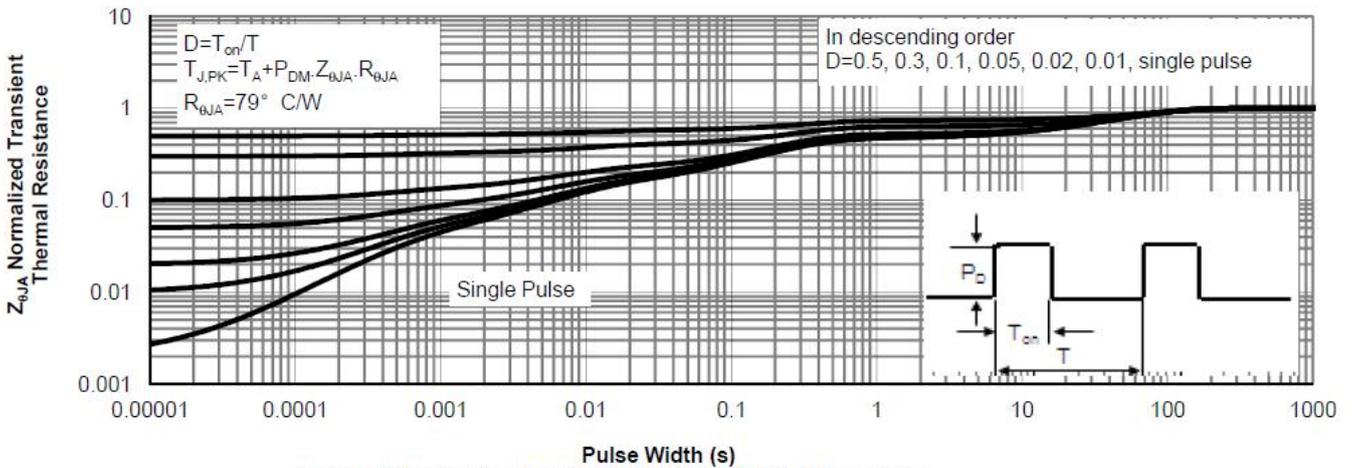


Figure 11: Normalized Maximum Transient Thermal Impedance

